Preferred Device

Power MOSFET

3.0 A, 60 V, Logic Level, N-Channel SOT-223

Designed for low voltage, high speed switching applications in power supplies, converters and power motor controls and bridge circuits.

Features

• Pb-Free Packages are Available

Applications

- Power Supplies
- Converters
- Power Motor Controls
- Bridge Circuits

MAXIMUM RATINGS ($T_C = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V _{DSS}	60	Vdc
Drain-to-Gate Voltage ($R_{GS} = 1.0 \text{ M}\Omega$)	V_{DGR}	60	Vdc
Gate–to–Source Voltage – Continuous – Non–repetitive (t _p ≤ 10 ms)	V _{GS}	± 15 ± 20	Vdc Vpk
$\label{eq:decomposition} \begin{split} & \text{Drain Current} \\ & - \text{Continuous } @ \text{ T}_{\text{A}} = 25^{\circ}\text{C} \\ & - \text{Continuous } @ \text{ T}_{\text{A}} = 100^{\circ}\text{C} \\ & - \text{Single Pulse } (t_{\text{p}} \leq 10 \mu\text{s}) \end{split}$	I _D I _D	3.0 1.4 9.0	Adc Apk
Total Power Dissipation @ $T_A = 25$ °C (Note 1) Total Power Dissipation @ $T_A = 25$ °C (Note 2) Derate above 25°C	P _D	2.1 1.3 0.014	Watts Watts W/°C
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to 175	°C
Single Pulse Drain-to-Source Avalanche Energy – Starting $T_J = 25^{\circ}C$ ($V_{DD} = 25 \text{ Vdc}, V_{GS} = 5.0 \text{ Vdc},$ $I_{L(pk)} = 7.0 \text{ Apk}, L = 3.0 \text{ mH}, V_{DS} = 60 \text{ Vdc})$	E _{AS}	74	mJ
Thermal Resistance -Junction-to-Ambient (Note 1) -Junction-to-Ambient (Note 2)	R _{θJA} R _{θJA}	72.3 114	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL	260	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

- When surface mounted to an FR4 board using 1" pad size, 1 oz. (Cu. Area 0.0995 in²).
- When surface mounted to an FR4 board using minimum recommended pad size, 2–2.4 oz. (Cu. Area 0.272 in²).

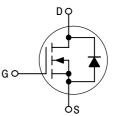


ON Semiconductor®

http://onsemi.com

3.0 A, 60 V $R_{DS(on)} = 120 \text{ m}\Omega$

N-Channel





SOT-223 CASE 318E STYLE 3

AYW

3055L•

MARKING DIAGRAM

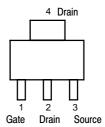
3055L = Device Code

A = Assembly Location Y = Year

W = Work Week ■ Pb–Free Package

(Note: Microdot may be in either location)

PIN ASSIGNMENT



ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

Preferred devices are recommended choices for future use and best overall value.

ELECTRICAL CHARACTERISTICS ($T_A = 25^{\circ}C$ unless otherwise noted)

Characteristic		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage (Note 3) $(V_{GS}=0\ Vdc,\ I_D=250\ \mu Adc)$ Temperature Coefficient (Positive)		V _{(BR)DSS}	60 -	68 68	_ _	Vdc mV/°C
Zero Gate Voltage Drain Current (V _{DS} = 60 Vdc, V _{GS} = 0 Vdc) (V _{DS} = 60 Vdc, V _{GS} = 0 Vdc, T _J = 150°C)		I _{DSS}	- -	- -	1.0 10	μAdc
Gate-Body Leakage Current (V _G	I _{GSS}	-	_	± 100	nAdc	
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage (Note 3) $ (V_{DS} = V_{GS}, I_D = 250 \ \mu Adc) $ Threshold Temperature Coefficient (Negative)		V _{GS(th)}	1.0	1.68 4.6	2.0	Vdc mV/°C
Static Drain-to-Source On-Resistance (Note 3) (V _{GS} = 5.0 Vdc, I _D = 1.5 Adc)		R _{DS(on)}	-	92	120	mΩ
Static Drain–to–Source On–Resistance (Note 3) $ (V_{GS} = 5.0 \text{ Vdc}, I_D = 3.0 \text{ Adc}) $ $ (V_{GS} = 5.0 \text{ Vdc}, I_D = 1.5 \text{ Adc}, T_J = 150^{\circ}\text{C}) $		V _{DS(on)}	_	0.290 0.250	0.43 -	Vdc
Forward Transconductance (Note 3)	(V _{DS} = 7.0 Vdc, I _D = 3.0 Adc)	9 _{fs}	-	5.7	-	Mhos
DYNAMIC CHARACTERISTICS				•	•	•
Input Capacitance		C _{iss}	-	313	440	pF
Output Capacitance	$(V_{DS} = 25 \text{ Vdc}, V_{GS} = 0 \text{ V}, $ f = 1.0 MHz)	C _{oss}	-	112	160	
Transfer Capacitance		C _{rss}	-	40	60	
SWITCHING CHARACTERISTICS (N	ote 4)					
Turn-On Delay Time		t _{d(on)}	-	11	25	ns
Rise Time	$(V_{DD} = 30 \text{ Vdc}, I_D = 3.0 \text{ Adc},$	t _r	-	35	70	1
Turn-Off Delay Time	$V_{GS} = 5.0 \text{ Vdc},$ $R_{G} = 9.1 \Omega) \text{ (Note 3)}$	t _{d(off)}	-	22	45	1
Fall Time		t _f	-	27	60	1
Gate Charge	$(V_{DS} = 48 \text{ Vdc}, I_{D} = 3.0 \text{ Adc}, V_{GS} = 5.0 \text{ Vdc}) \text{ (Note 3)}$	Q _T	-	7.6	15	nC
		Q ₁	_	1.4	-	1
		Q ₂	-	4.0	_	
SOURCE-DRAIN DIODE CHARACTE	RISTICS				1	
Forward On-Voltage	$(I_S = 3.0 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$ $(I_S = 3.0 \text{ Adc}, V_{GS} = 0 \text{ Vdc},$ $T_J = 150^{\circ}\text{C}) \text{ (Note 3)}$	V _{SD}	_ _	0.87 0.72	1.0	Vdc
Reverse Recovery Time		t _{rr}	-	35	-	ns
	$(I_S = 3.0 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, \\ dI_S/dt = 100 \text{ A/µs}) \text{ (Note 3)}$	t _a	-	21	_	1
		t _b	-	14	_	1
Reverse Recovery Stored Charge	ļ	Q _{RR}	-	0.044	-	μС

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2.0%.
 Switching characteristics are independent of operating junction temperatures.

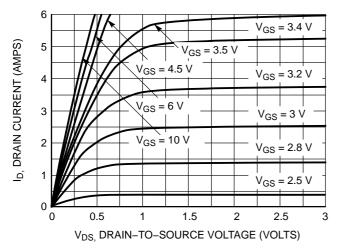


Figure 1. On-Region Characteristics

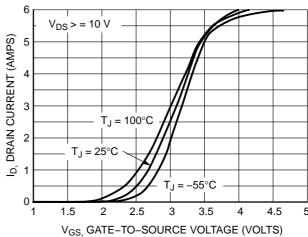


Figure 2. Transfer Characteristics

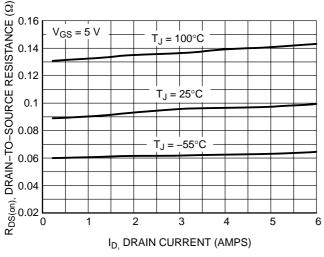


Figure 3. On-Resistance vs. Gate-to-Source Voltage

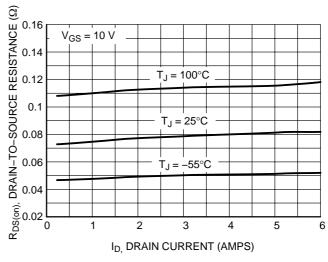


Figure 4. On-Resistance vs. Drain Current and **Gate Voltage**

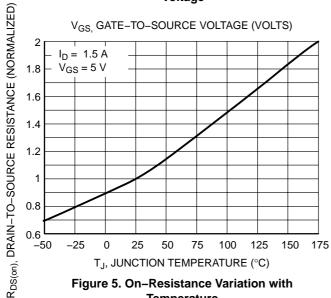


Figure 5. On-Resistance Variation with **Temperature**

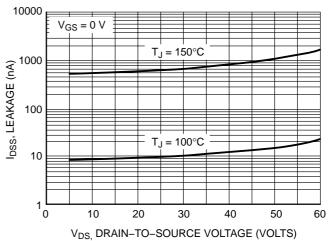


Figure 6. Drain-to-Source Leakage Current vs. Voltage

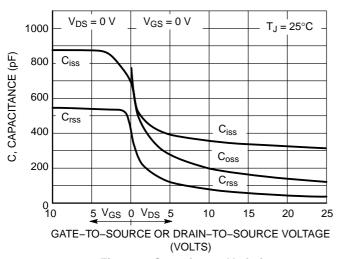


Figure 7. Capacitance Variation

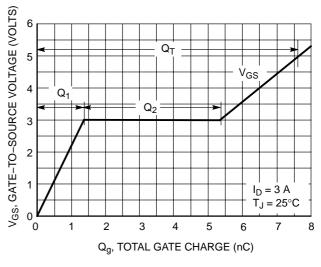


Figure 8. Gate-to-Source and

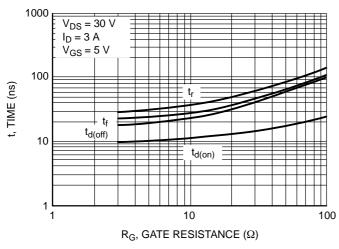


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

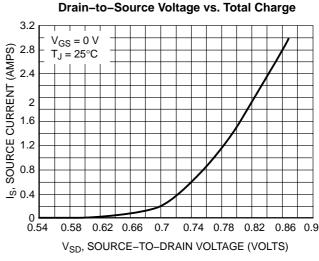


Figure 10. Diode Forward Voltage vs. Current

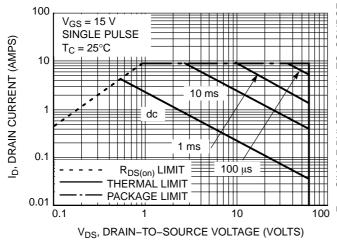


Figure 11. Maximum Rated Forward Biased Safe Operating Area

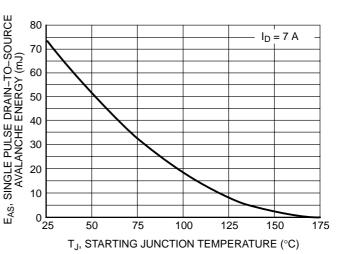


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

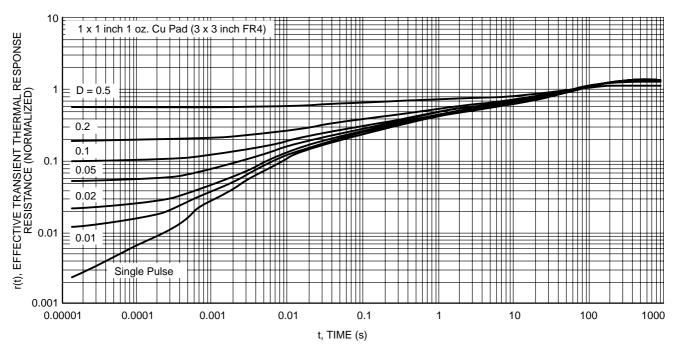


Figure 13. Thermal Response

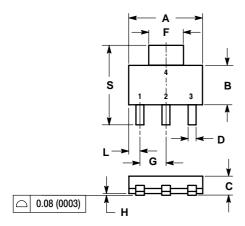
ORDERING INFORMATION

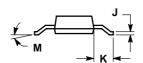
Device	Package	Shipping [†]
NTF3055L108T1	SOT-223 (TO-261)	1000 / Tape & Reel
NTF3055L108T1G	SOT-223 (TO-261) (Pb-Free)	1000 / Tape & Reel
NTF3055L108T3	SOT-223 (TO-261)	4000 / Tape & Reel
NTF3055L108T3G	SOT-223 (TO-261) (Pb-Free)	4000 / Tape & Reel
NTF3055L108T3LF	SOT-223 (TO-261)	4000 / Tape & Reel
NTF3055L108T3LFG	SOT-223 (TO-261) (Pb-Free)	4000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

SOT-223 (TO-261) CASE 318E-04 ISSUE K





NOTES:

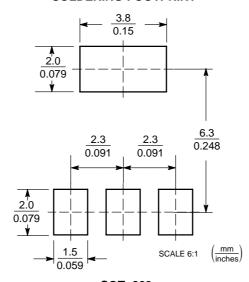
- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 - 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.249	0.263	6.30	6.70
В	0.130	0.145	3.30	3.70
С	0.060	0.068	1.50	1.75
D	0.024	0.035	0.60	0.89
F	0.115	0.126	2.90	3.20
G	0.087	0.094	2.20	2.40
Н	0.0008	0.0040	0.020	0.100
J	0.009	0.014	0.24	0.35
K	0.060	0.078	1.50	2.00
L	0.033	0.041	0.85	1.05
M	0 °	10 °	0 °	10 °
S	0.264	0.287	6.70	7.30

STYLE 3: PIN 1. GATE 2. DRAIN

2. DRAIN 3. SOURCE 4. DRAIN

SOLDERING FOOTPRINT*



SOT-223

*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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